

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF:

•

TOMOHARU TANAKA ET AL

: ATTN: APPLICATION DIVISION

SERIAL NO: NEW APPLICATION

FILED: HEREWITH

FOR: NONVOLATILE SEMICONDUCTOR:

MEMORY DEVICE

PRELIMINARY AMENDMENT

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Prior to a first examination on the merits, please amend the above-identified application as follows:

IN THE SPECIFICATION

Page 3, line 10, change "restriction" to --restrictions--.

Page 5, line 16, after "cell" insert -/,--;

line 17, after "written" insert --,--;

line 21, after/"state" insert --at/first--,

same line, after "and" insert --is--.

Page 6, line 8, change "the" (first occurrence) to --a--

Page 7, line 8, change "the" (first occurrence) to --a/-.

Page 11, line 4, before "maximum" insert'--a--.

Page 17, line 7, change "the" (first occurrence) to